







CONTAC	T ANGLE MEASUREMENT	
Brand	OCA-20 Contact Angle Measuring Instrument (DataPhysics Instruments GmbH)	
Liquid	Water, hexadecane	
Output	Contact angle	
Contact angle mea A total of 10 drops the left and right si	asurements can be done on flat surfaces to determine its hyd will be placed on the to be measured surface which are then de of the droplet is than calculated, after which an average o	rophobic or hydrophilic behavior. imaged by a camera. Via software the contact angle at ver the 10 droplets will be given.
With contact angle	measurements a variation of +/- 3° in between measurement	ts is within the tolerance limits.
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Brand	TA Instruments Q800 DMTA	
Temperature range	-140 to 600 °C	The second se
Frequency range	0.01 – 200 Hz	
Maximum force	18 N	
Modes & Sample Size (LxWxT [mm])	Dual / single cantilever: 35/17.5 x <15 x <5	
Output	Storage and loss modulus, Tan Delta, Frequency, Static/Dynamic force, Discplacement, Shrinkage, Creep, Relaxation, Stress-strain, CTE, TTS.	
MTA is a technique use he DMTA measuremen DMTA diagram shows	ed to analyze the viscoelastic behavior of a material as a funct t results are used for determining thermal transisions suchs a the stiftness (storage and loss modulus) as a function of term	ion of temperature or frequency. s the glass transition temperature (T _g).

🧖 🤧 GAS CHRC	MATOGRAPHY MASS SPE	CTROMETRY (GC-MS)
Brand	PerkinElmer Clarus 690 GC & PerkinElmer SQ8T MS	A
Carrier Gas	Helium	
Output	Mass spectrum Material identification	
Gas Chromatograph	y combined with Mass Spectrometry is a way to ide	ntify or quantify (semi) volatile compounds.
The sample is injected are than detected with The obtained mass s	ed into the GC-MS and separated based on boiling th a Mass Spectrometer resulting in a mass spectru spectra are run through the NIST database to identi	point and affinity with the column. The separated components im unique for a material. fy the detected components.
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Brand	PerkinElmer Frontier IR	
IR range	600 to 4.000 cm ⁻¹	
Typical sample size	1x1 cm or 10 mg	
IR modes	ATR (reflection) Transmission	
R spectroscopy is used he material. R spectroscopy can be powder (10 mg), or ever	to record an IR spectrum of a material that is used to identify an unknown organic materia n contaminants of up to 50 μm diameter.	s unique to that type of material, in other words a fingerprint of I. Samples may vary from a small piece of a product (1x1 cm), a
For this kind of identifica for comparing different n	ition, PTG/e has an extensive database of IR naterial batches as identical materials have a	-spectra. IR analysis is also an excellent method in identical IR spectrum.







<u>b</u> OPTICAL N	/IICROSCOPY	
Brand	Motic Stereo SMZ-168T-LED	4
Magnification range	7.5x to 50x	
Lighting options	Transmitted/incident LED illumination Crossed polars	
Output	Magnified image of the sample	
A stereo microscope is 3D. Measurements are option to save the imag A stereo microscope ca	s a microscope with two objective lenses and carried out with a Motic Stereo SMZ-168T-L jes. an be used to obtain a first impression of the st	two eyepieces, which makes it possible to visualize a sample in ED microscope with a magnification range of 7.5x to 50x and the urface of a sample and for sample preparation.
SERVICE ANALYSIS AT PTG/e		MATERIAL INNOVATORS



<u>b</u> ø PTG SCANNING ELECTRON MICROSCOPY (SEM) EINDHOVEN Brand Quanta 3D FEG Magnification 30x to 1,000,000x Energy Dispersive X-Ray (EDX) for elemental analysis. Combined with Typical Sample size <1 µm - 2 cm High resolution images Output Elements present An electron microscope produces images of the surface of a sample with the help of an electron beam. This technique enables much larger magnifications than are possible with an optical microscope. Measurements are carried out with a FEI Quanta 3D FEG SEM, which enables magnifications of 30x to 1,000,000x with a resolution of 2 nm. In addition, an EDX (Energy Dispersive X-ray) probe is available for identifying the elements present in the sample. SEM analysis makes it possible to visualize sample surfaces in great detail. Furthermore, (very) small impurities or foreign elements in a sample can be visualized and identified by means of elemental analysis. MATERIAL INNOVATORS

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PCE instruments PCE-DD Shore A and Shore D	
Shore A and Shore D	
	000
> 6 mm thick	
Flat surface	H of me
0-100	
Hardness (Shore A or D)	
ale indicates the resistance of a material to i erial and pressure is applied. Once the durc an go, the corresponding shore hardness can	indentation. A Shore durometer has a needle on a spring which is ometer is pressed firmly against the material and the needle has n be read from the display.
	 > 33x33 mm wide Flat surface 0-100 Hardness (Shore A or D) ale indicates the resistance of a material to rial and pressure is applied. Once the durn n go, the corresponding shore hardness car









🤊 🕼 🌰 TGA - IR H	PHENATION	
Brand	PerkinElmer TGA4000 & PerkinElmer Frontier IR	\cap
Temperature range	35 to 1,000 °C	
Typical sample size	10 mg	
Type of TGA pans	Ceramic sample pans	
Atmosphere	Nitrogen or Air	
Output	Identification of gasses during TGA measurement	
The two techniques of T Measurements are carri Samples can be measu online in the IR spectror The method can be use result of degradation. In	GA and IR spectroscopy can be combined f led out with a PerkinElmer TGA 4000 couple red over a temperature range of 35 to 1,000 meter. d to determine whether mass loss in a samp the case of multi-component systems, the c	o obtain additional information on a material. d to a gas cell in a PerkinElmer Frontier FT-IR spectrometer. °C in nitrogen or air, with the gases released being measured le has to do with evaporation of specific components or is the order of evaporation can also be established.
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